

# Deutsche Akkreditierungsstelle GmbH

# Annex to the Accreditation Certificate D-K-21312-01-00 according to DIN EN ISO/IEC 17025:2018

 Valid from:
 31.05.2022

 Date of issue
 31.05.2022

Holder of certificate:

Carl Zeiss GOM Metrology GmbH Schmitzstraße 2, 38122 Braunschweig

Calibration in the fields:

**Dimensional quantities** 

- Coordinate measuring technology
- Application coordinate measuring machines

The management system requirements of DIN EN ISO/IEC 17025 are written in the language relevant to the operations of calibration laboratories. Laboratories that conform to the requirements of this standard, operate generally in accordance with the principles of DIN EN ISO 9001.

The certificate together with the annex reflects the status as indicated by the date of issue. The current status of any given scope of accreditation can be found in the directory of accredited bodies maintained by Deutsche Akkreditierungsstelle GmbH at https://www.dakks.de/en/accredited-bodies-search.html.

Abbreviations used: see last page

This document is a translation. The definitive version is the original German annex to the accreditation certificate.



### Annex to the accreditation certificate D-K-21312-01-00

#### **Permanent Laboratory**

# Calibration and Measurement Capabilities (CMC)

Measurement quantity / Calibration item		Rar	ige		Measurement conditions / procedure	Expanded uncertainty of measurement <sup>1)</sup>	Remarks
Length Three dimensional coordinate standards for optical metrology	X:	-65 mm	to	+65 mm	CL-GOM-V001-R01:X-Y-coordinate2021-03-021.1 $\mu$ mThree dimensional photogrammetric measurement of circle center coordinates by an automatic measuring cameraZ-coordinate1.1 $\mu$ mX-Y-coordinate2.1 $\mu$ mX-Y-coordinate3.1 $\mu$ mX-Y-coordinate<	X-Y-coordinate	
	Υ:	-60 mm	to	+60 mm		1.1 μm	
	Z:	-5 mm	to	+5 mm		Z-coordinate 2.1 μm	
	Х:	-165 mm	to	+165 mm		X-Y-coordinate	K= X, Y
	Υ:	-125 mm	to	+125 mm		1.1 μm + 3 · 10 <sup>-6</sup> ·   <i>K</i>	
	<i>Z:</i>	-5 mm	to	+5 mm		<i>Z-coordinate</i> 2.1 μm	
	X:	-350 mm	to	+350 mm		X-Y-coordinate	
	<i>Y</i> :	-250 mm	to	+250 mm		2.1 μm + 16 · 10 <sup>-6</sup> ·   <i>K</i>	
	<i>Z</i> :	-10 mm	to	+10 mm		<i>Z-coordinate</i> 4.1 μm	
	X:	-1100 mm	to	+1100 mm		X-Y-coordinate	
	<i>Y</i> :	-700 mm	to	+700 mm		4.1 μm + 16 · 10 <sup>-6</sup> ·   <i>K</i>	
	Z:	-10 mm	to	+10 mm		<i>Z-coordinate</i> 8.8 μm	
Length standards for optical metrology		>0 mm	to	260 mm	CL-GOM-V001-R01:	1.5 μm + 1.5 · 10 <sup>-6</sup> · <i>L</i>	L= measured
		> 260 mm	to	510 mm	2021-03-02	2.7 μm + 1.8 · 10 <sup>-6</sup> · <i>L</i>	length
		> 510 mm	to	2400 mm	Three dimensional photogrammetric measurement of circle center coordinates by an automatic measuring camera and calculation of the Euclidean distance	4.5 μm + 2.5 · 10 <sup>-6</sup> · <i>L</i>	

# Abbreviations used:

CL-GOM-V	Procedure instruction of Carl Zeiss GOM Metrology GmbH
CMC	Calibration and measurement capabilities

<sup>1)</sup> The expanded uncertainties according to EA-4/02 M:2013 are part of CMC and are the best measurement uncertainties within accreditation. They have a coverage probability of approximately 95 % and have a coverage factor of k = 2 unless stated otherwise. Uncertainties without unit are relative uncertainties referring to the measurement value unless stated otherwise.

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